

Charge transport mechanisms in GRM thin films: interplay between different length scales

Alex Boschi

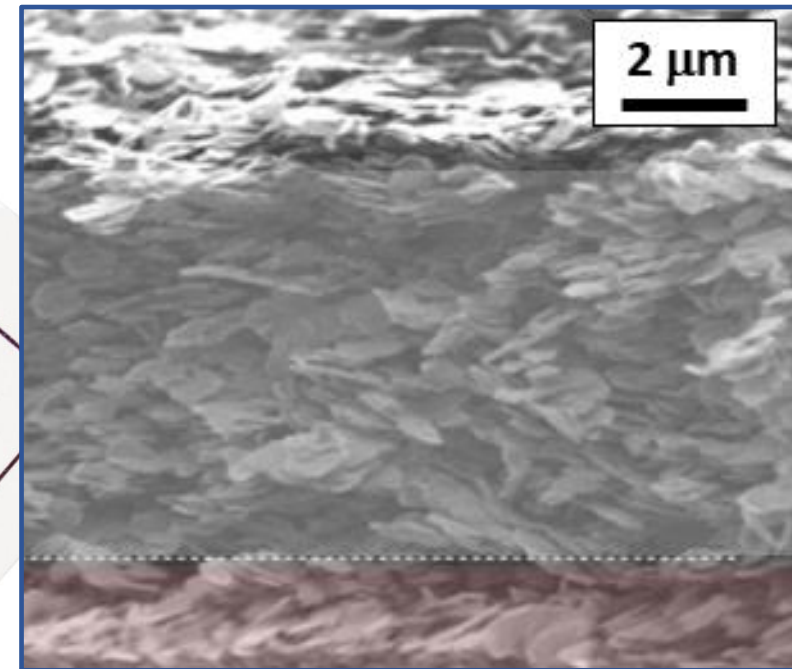
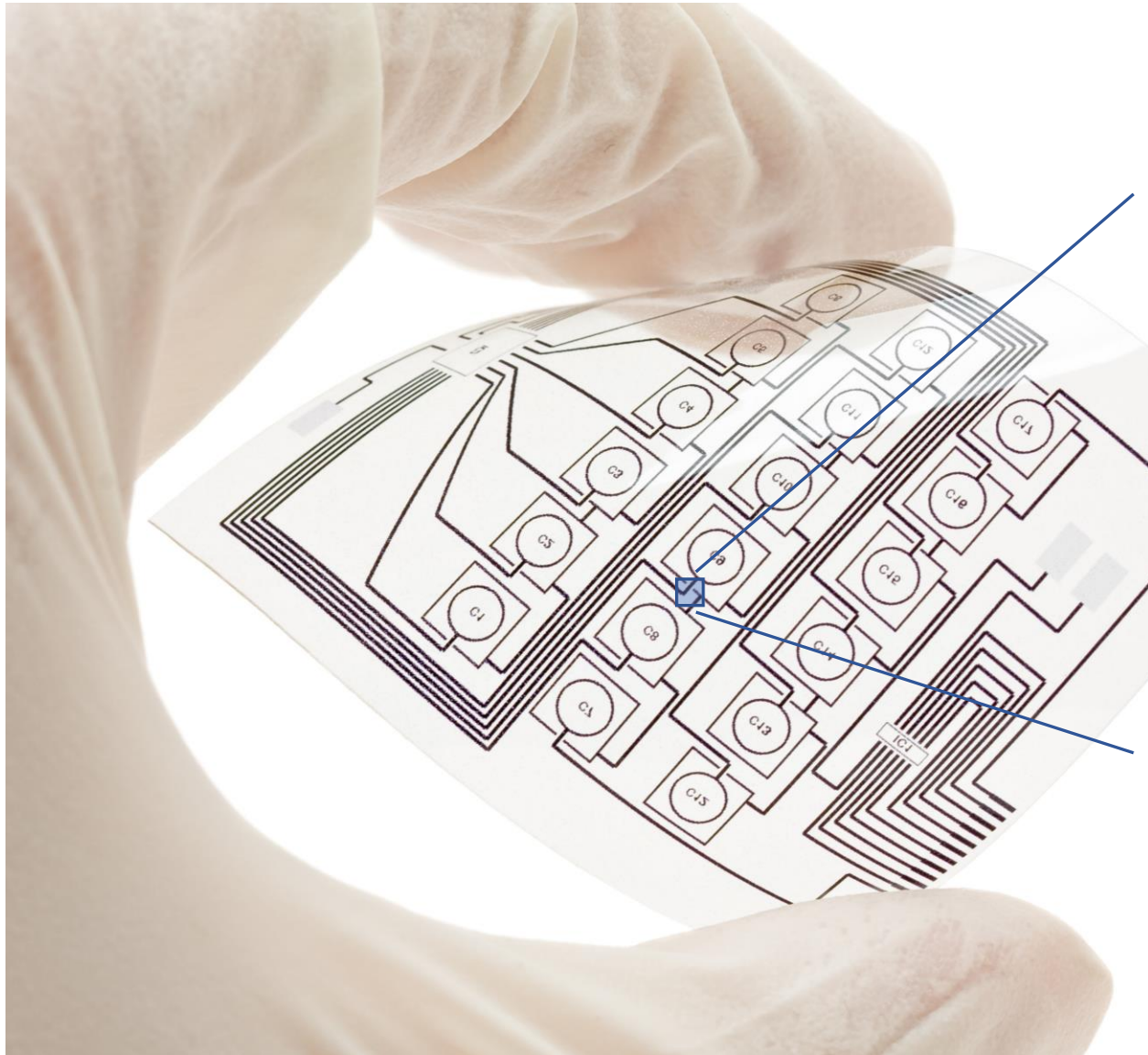
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- Purpose of the work
- Structural characterization of GRM samples
- Charge transport in GRM thin films

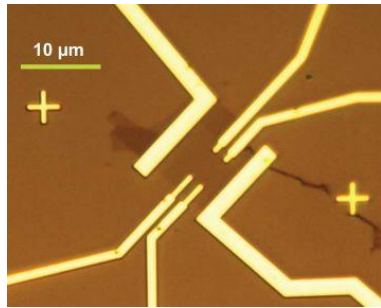
2-Dimensional materials printed electronic devices



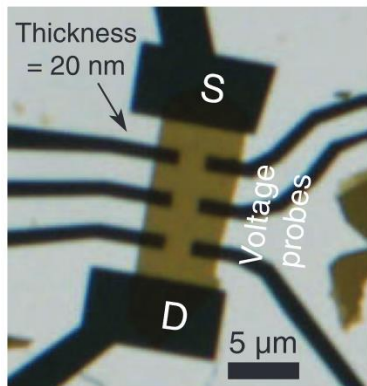
Kelly *et al.*, *Science* 356, 6333 (2017)



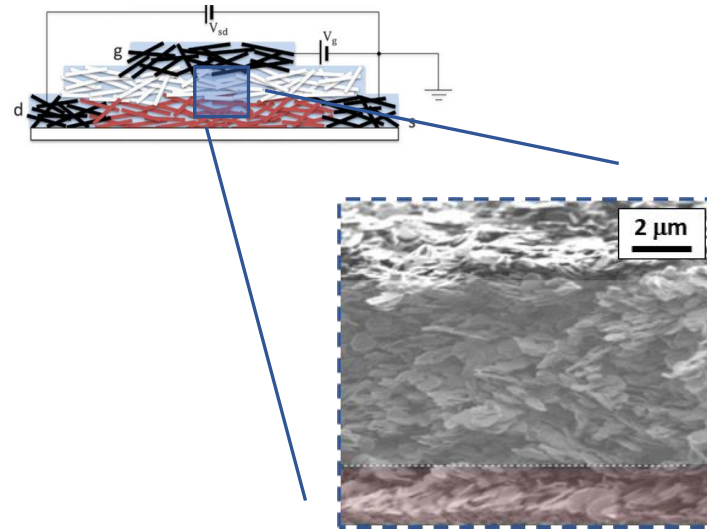
Charge transport in single sheet devices



Joung *et al.*, *Phys. Rev. B* 86, 235423 (2012)

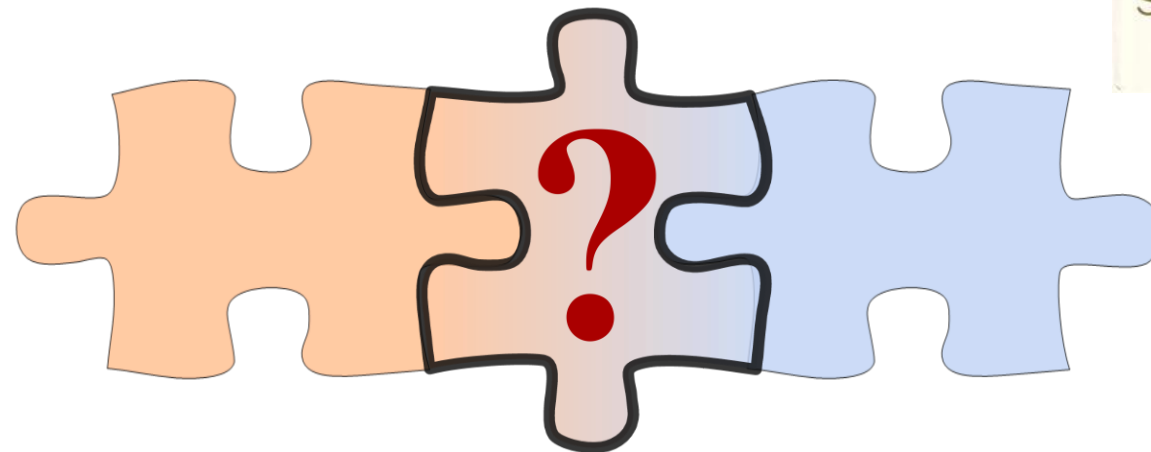
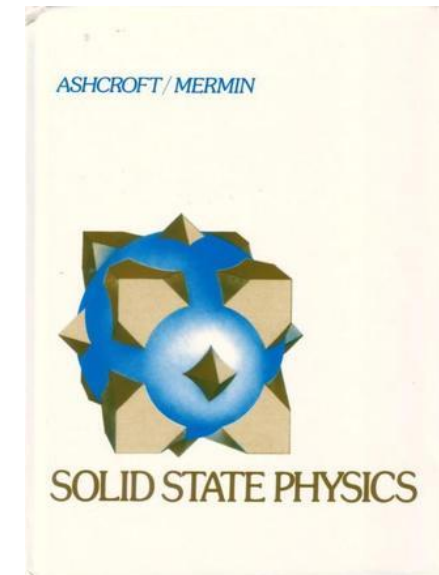


Ye *et al.*, *Science* 338, 1193 (2012)



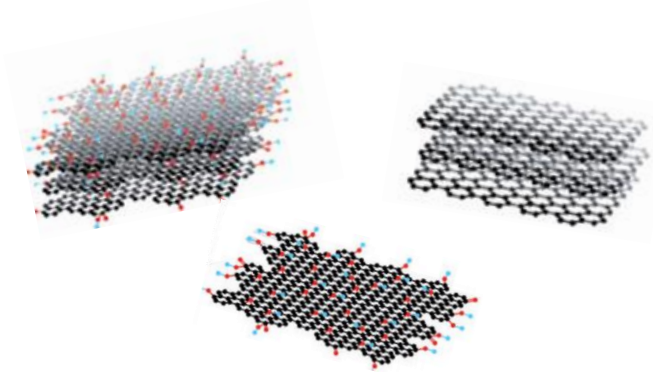
Kelly *et al.*, *Science* 356, 6333 (2017)

Charge transport in bulk systems

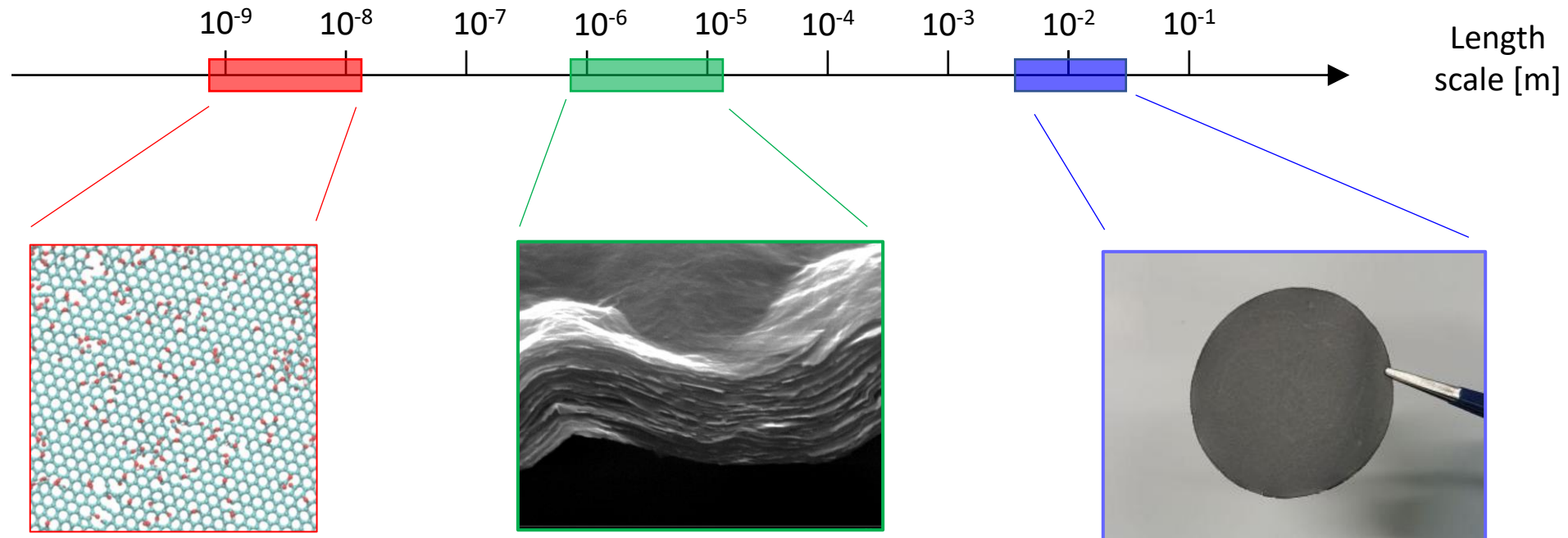




Graphene-related Materials (GRM)



- ✓ 2D materials
- ✓ wide portfolio of processing methods
- ✓ (some) commercially available



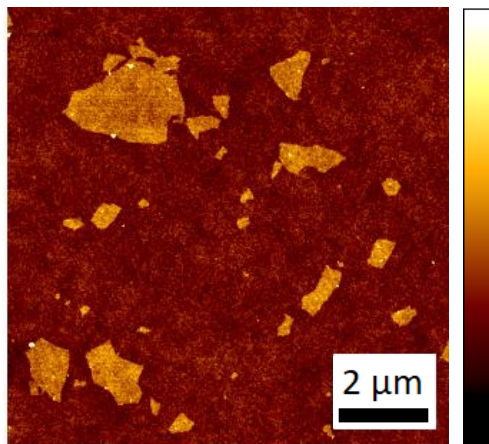
Two different GRM nanosheets



Reduced Graphene Oxide (RGO)

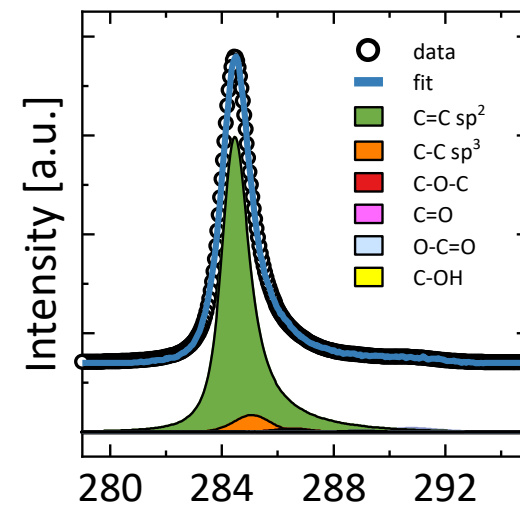
- ✓ purely 2D material
- ✓ negligible oxygen content

AFM



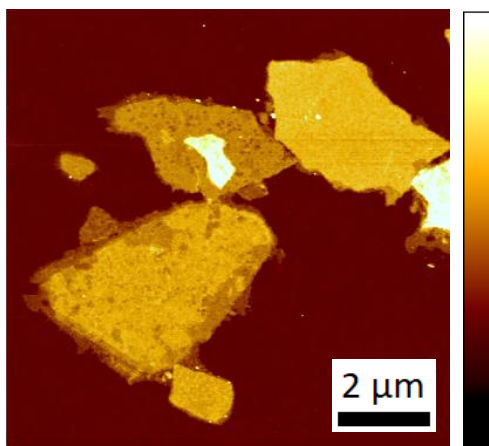
z-range: 2.5 nm

XPS

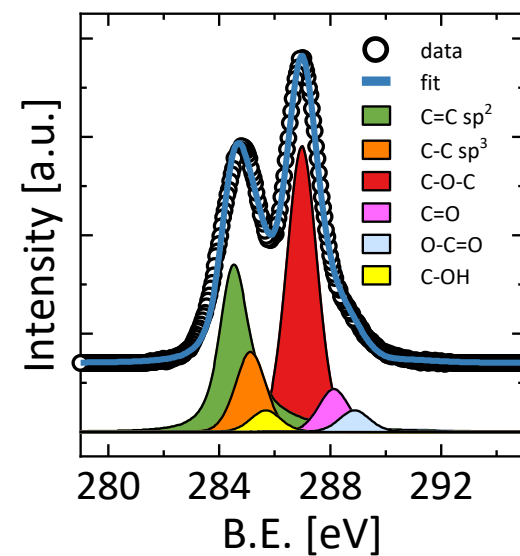


Electrochemical Exfoliated GO (EGO)

- ✓ multilayer nanosheets
- ✓ oxygen functionalities

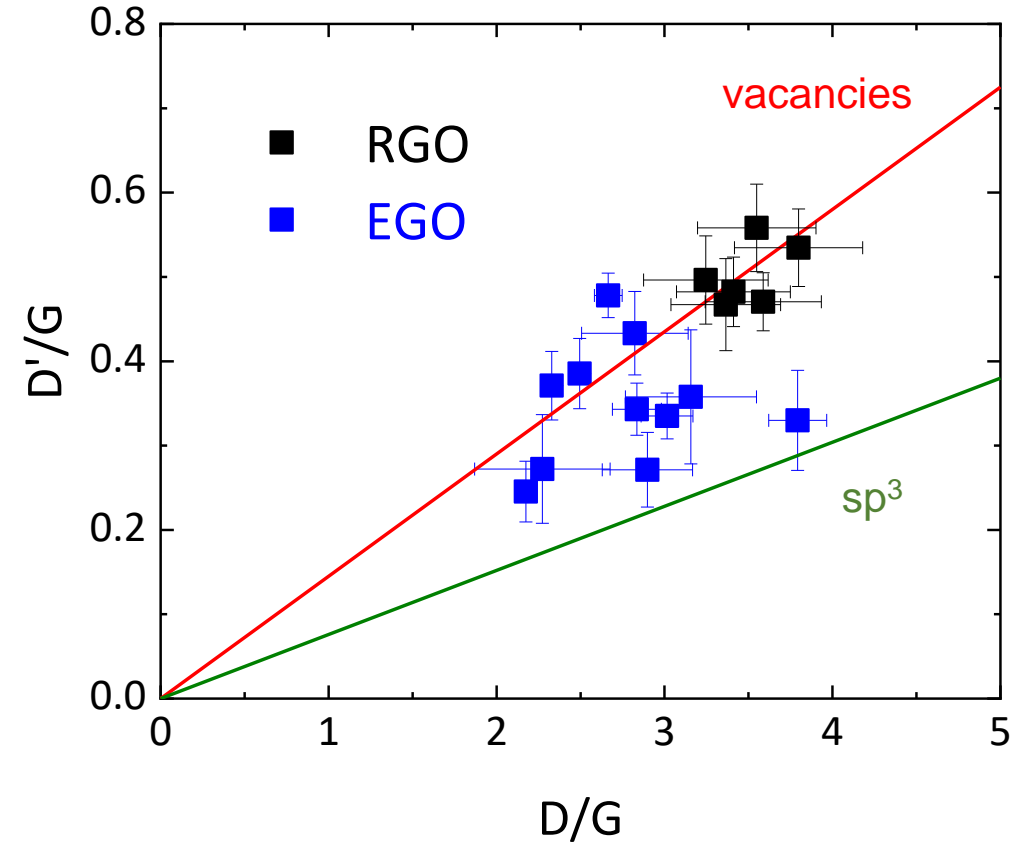
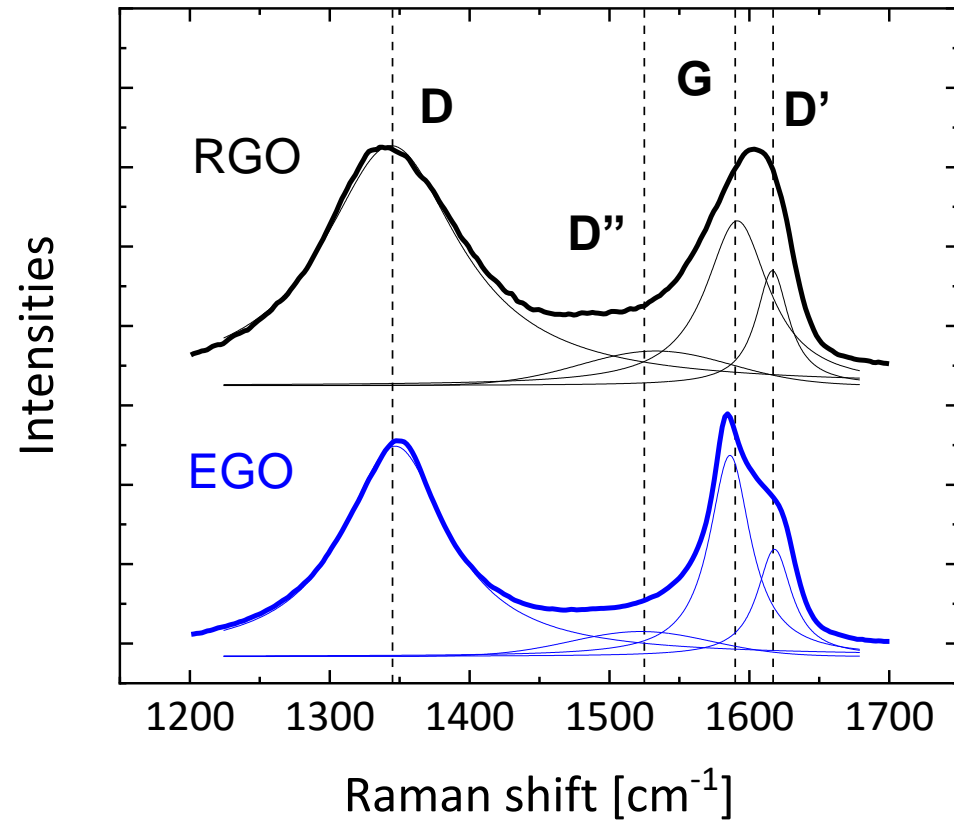


z-range: 11 nm



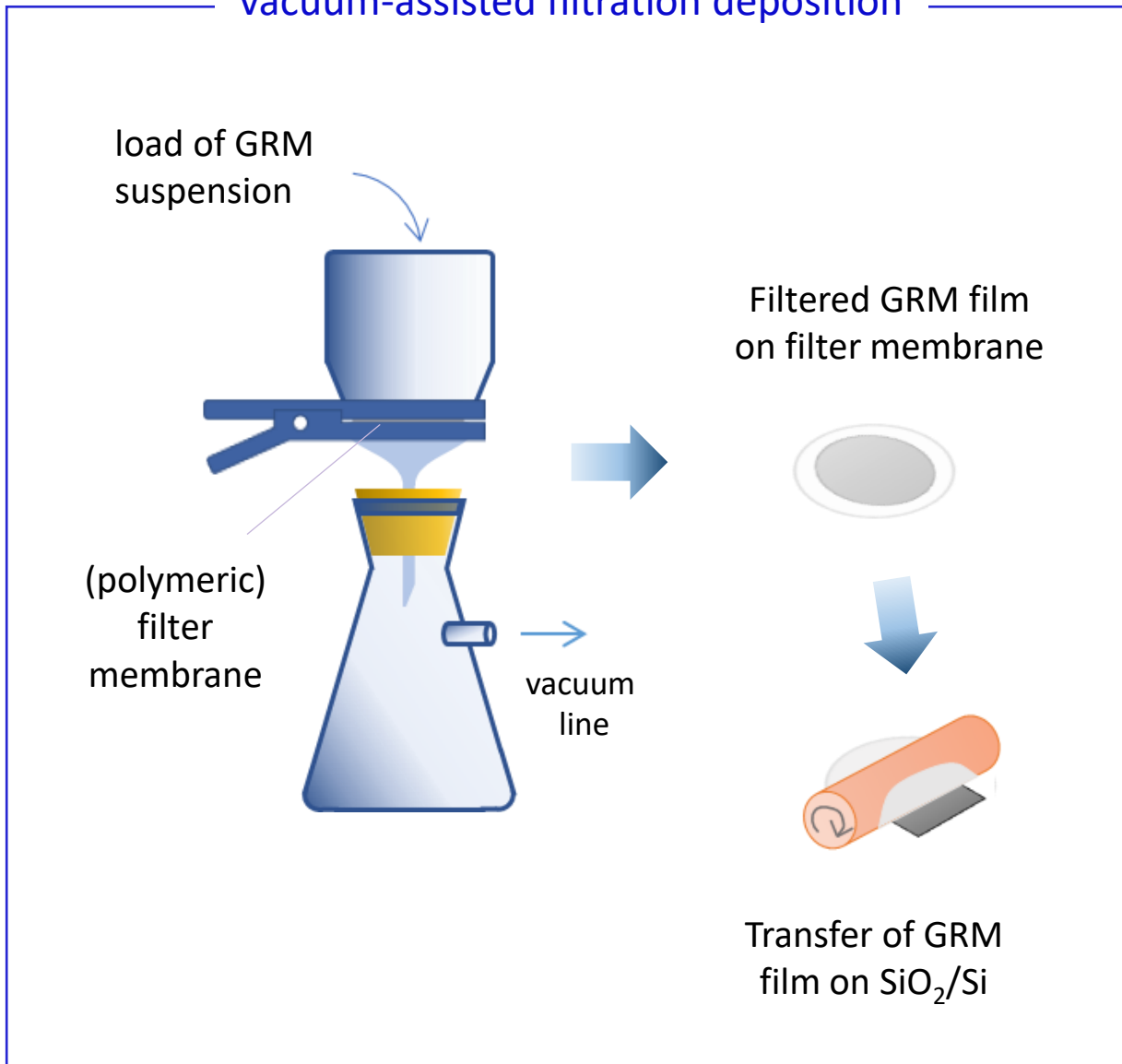


representative Raman spectra

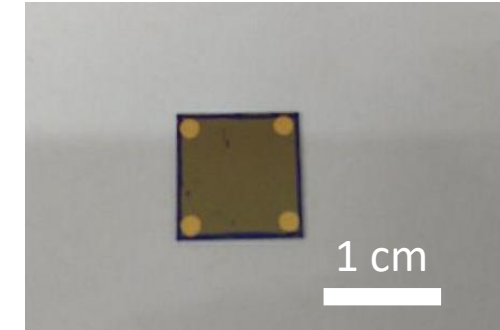




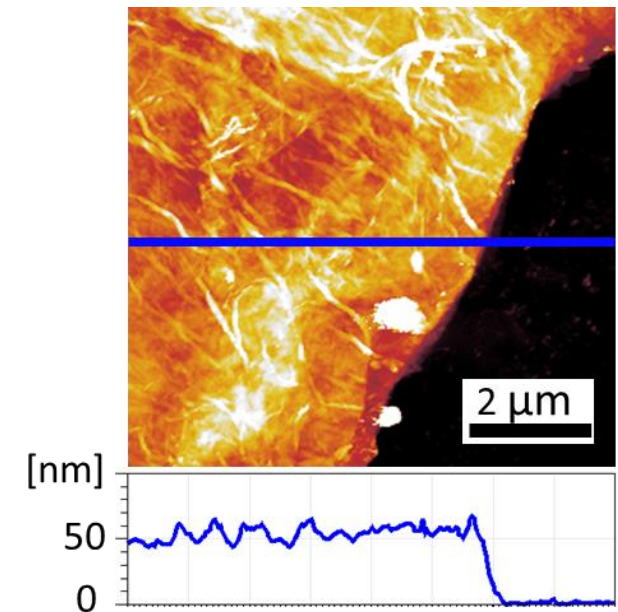
vacuum-assisted filtration deposition



photograph of a film



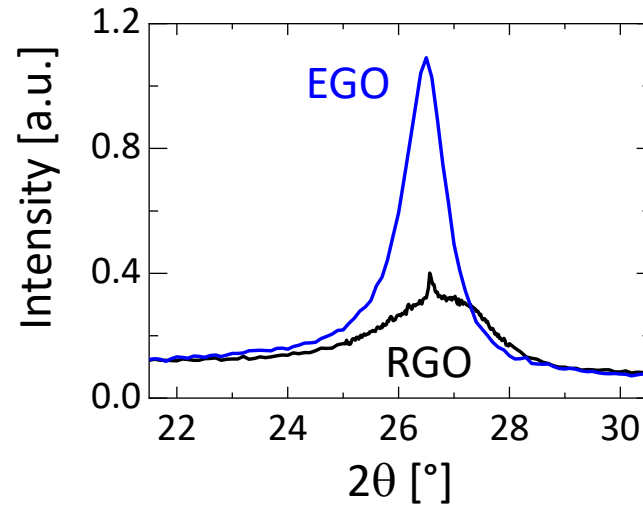
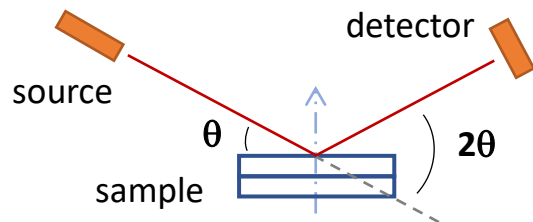
AFM image



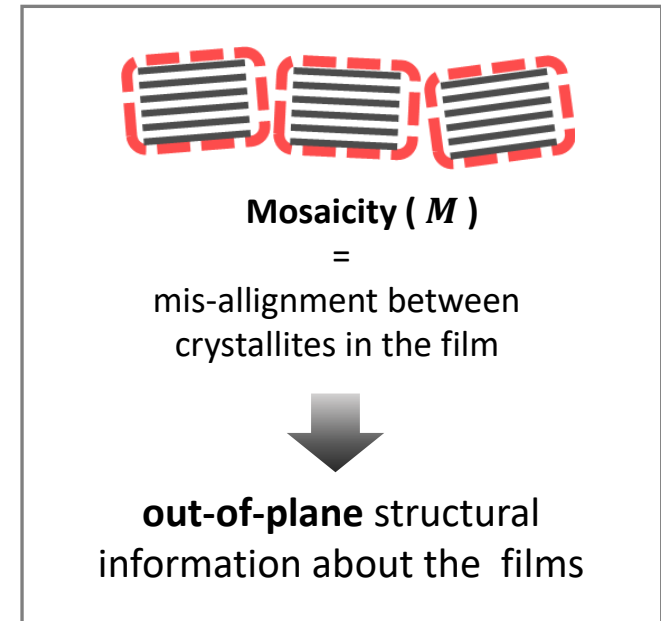
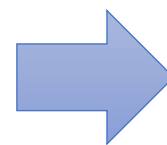
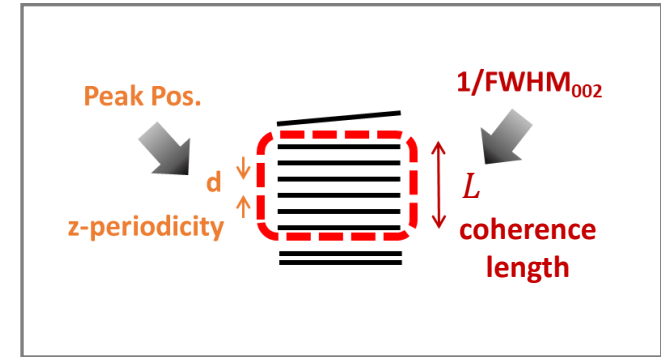
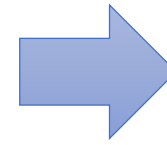
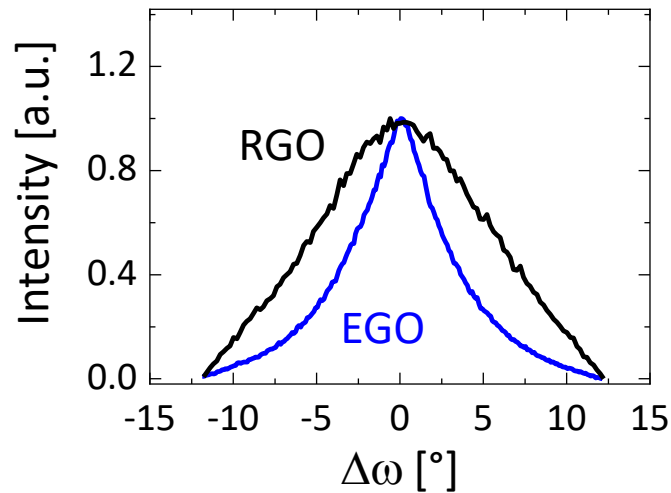
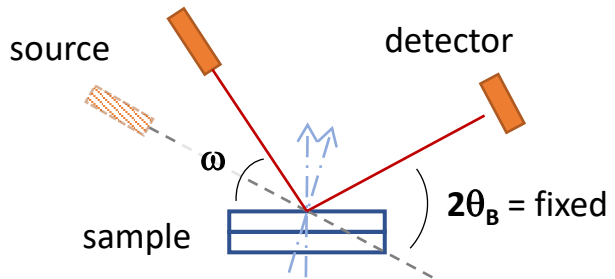


XRD measurements on GRM films

Specular Scan θ - 2θ



Rocking Curve

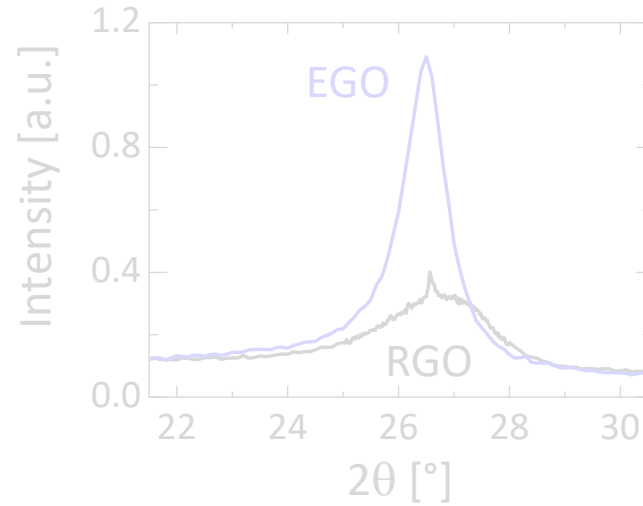
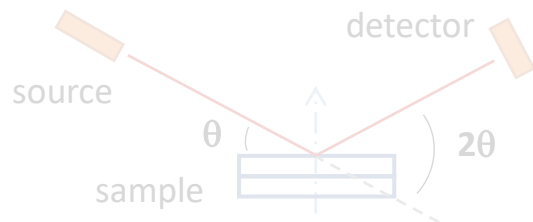


Film network structure: RGO vs. EGO

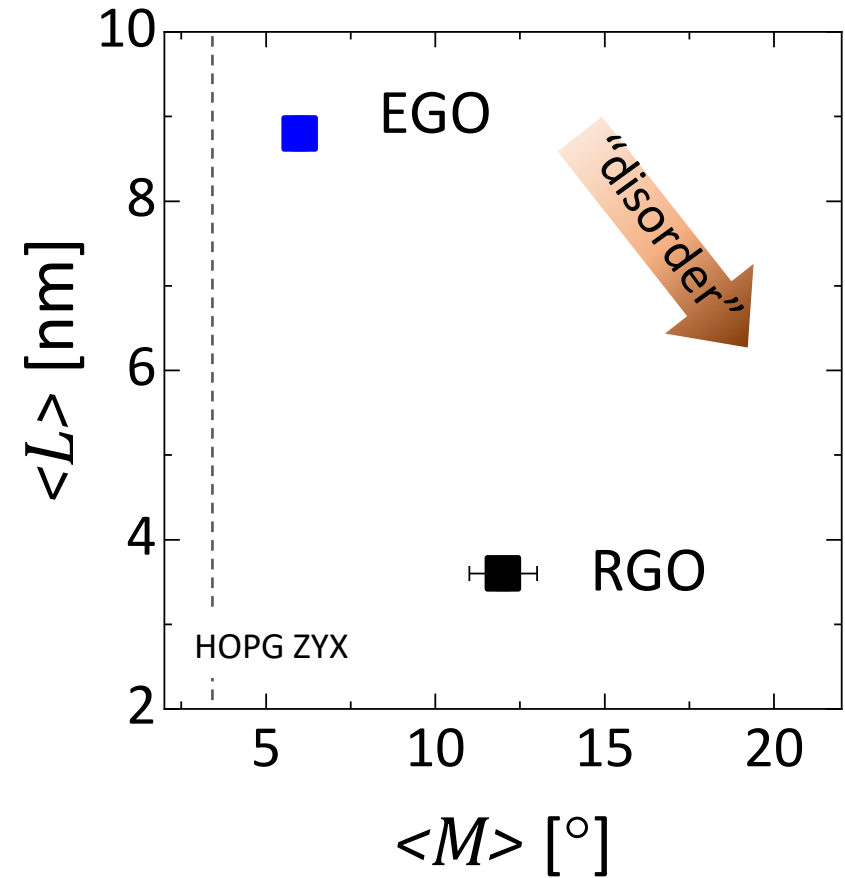
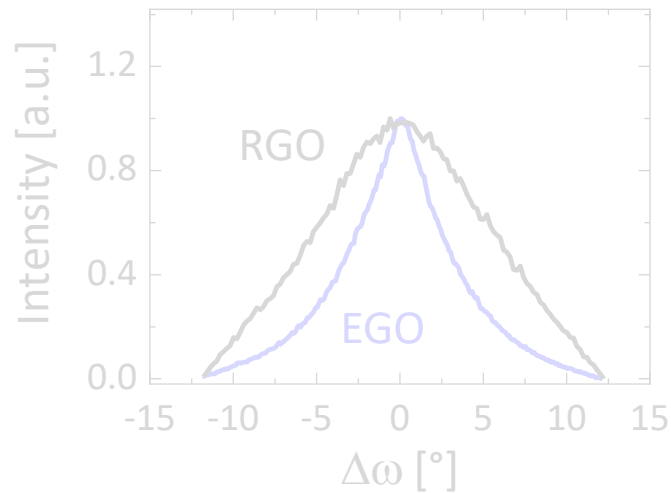
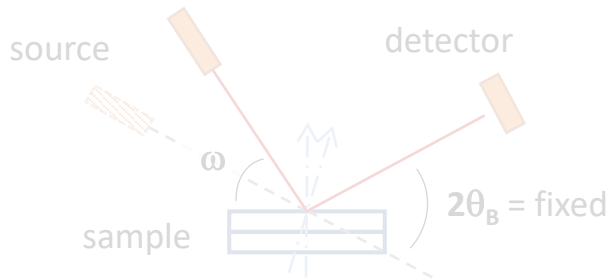


XRD measurements on GRM films

Specular Scan θ - 2θ

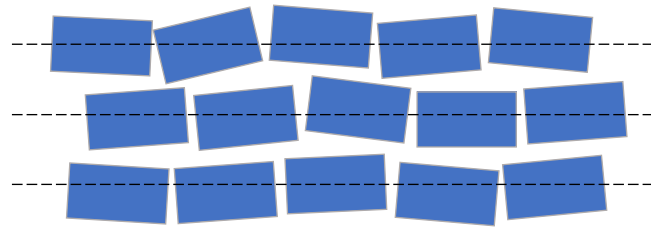


Rocking Curve





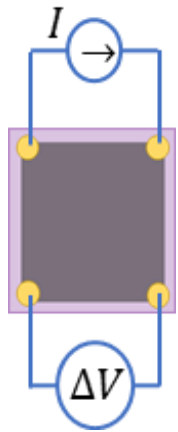
RGO



EGO

few stacked single sheets

a partially oxidised
single flake



resistivity of similar order: $10^{-5} \Omega \cdot \text{m}$!

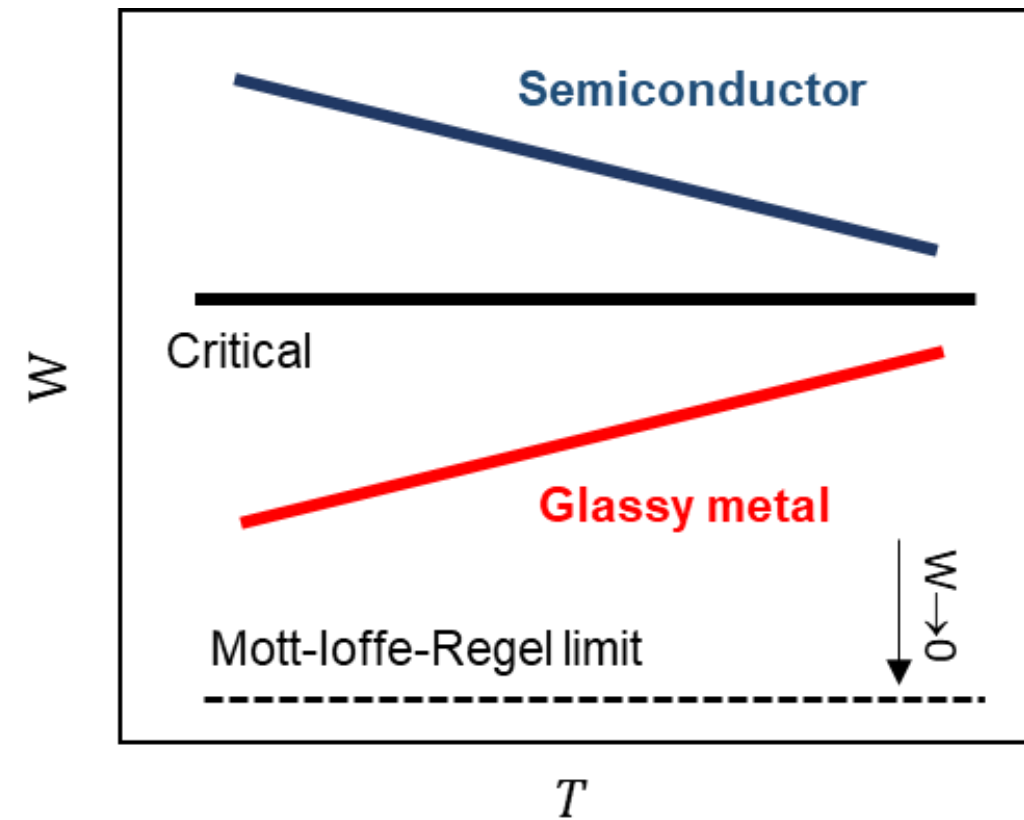
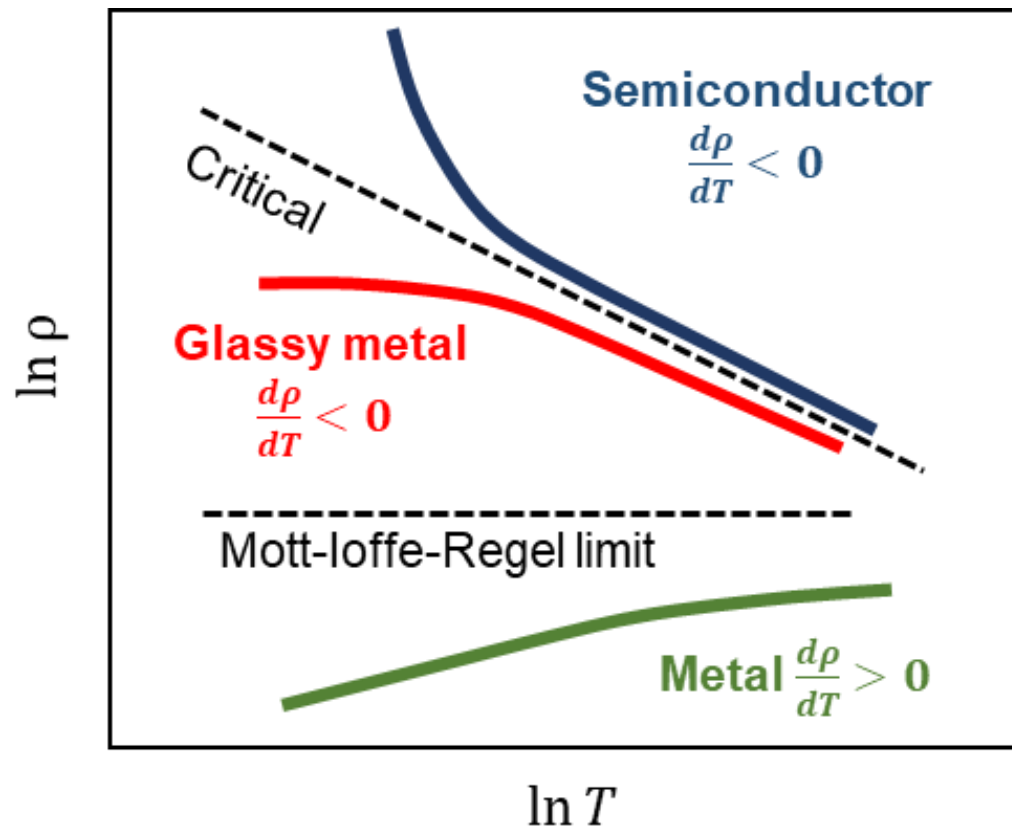
room temperature

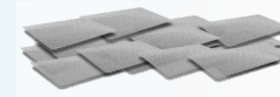


resistivity ρ as a function of temperature

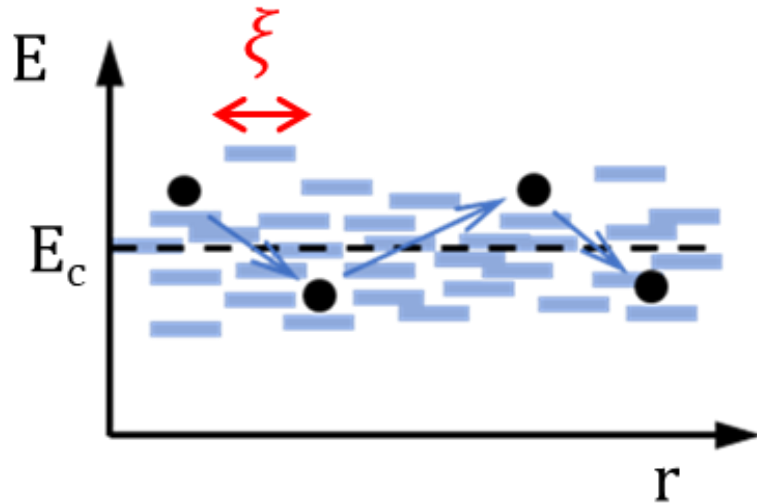
activation energy

$$W = - \frac{\partial \ln \rho(T)}{\partial \ln T}$$



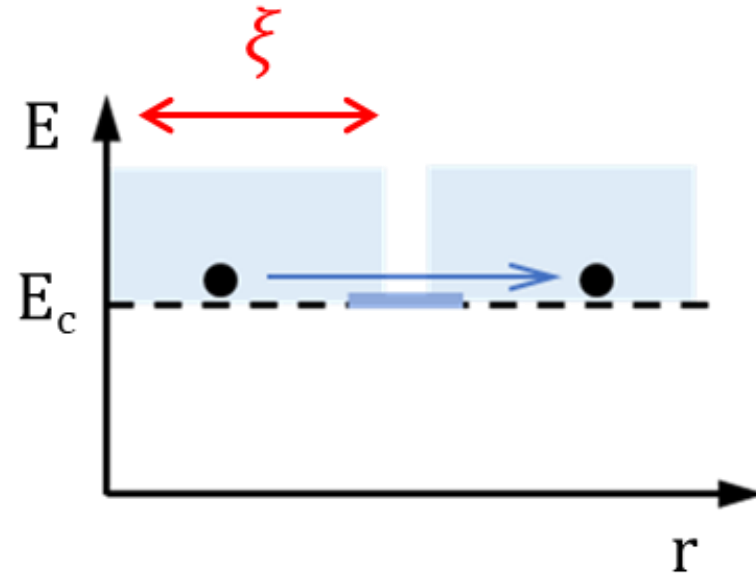


Variable Range Hopping (VRH)



Power law (PL)

- ✓ critical regime
- ✓ nuclear tunnelling
- ✓ etc



➔ $\rho(T) \sim e^{\left(\frac{T_0}{T}\right)^p}$

p depends on Density of States $g(\mu_F)$ shape

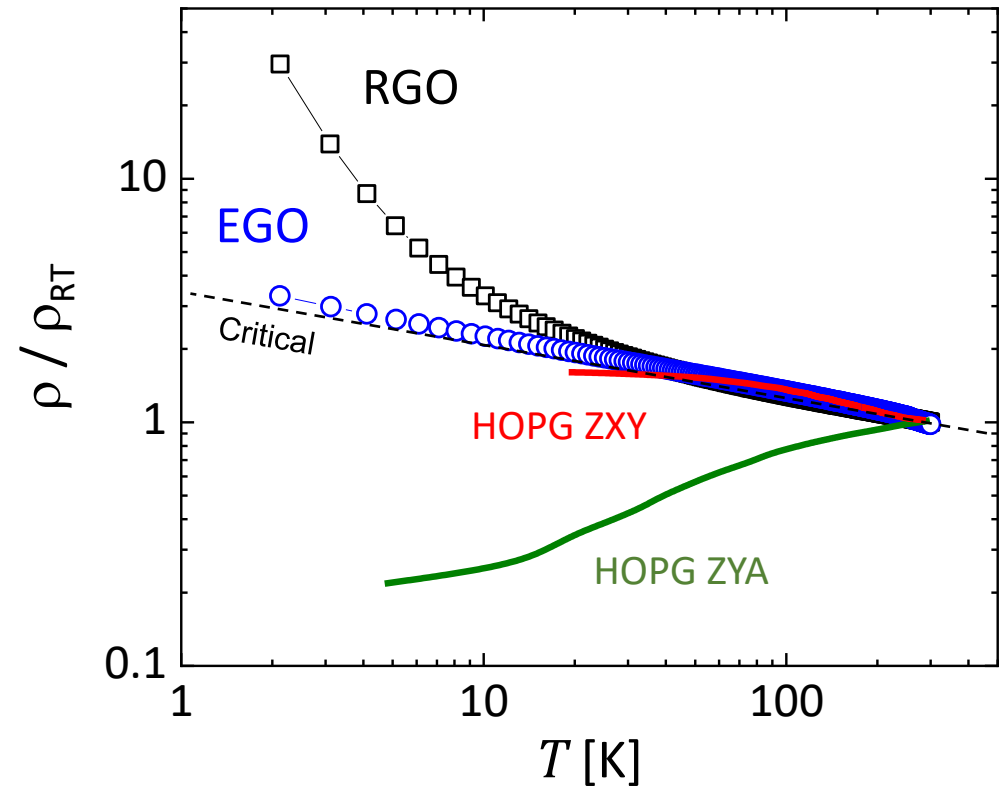
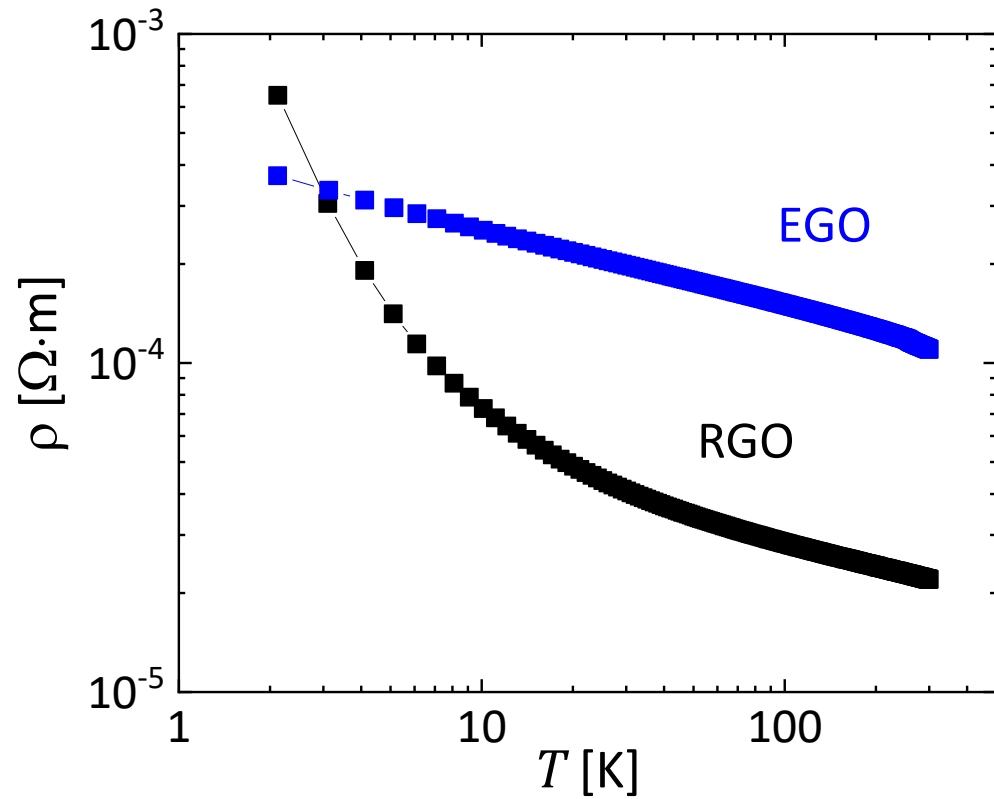
p	
1/2	1D system, $g(\mu_F) \neq 0$
1/3	2D system, $g(\mu_F) \neq 0$
1/4	3D system, $g(\mu_F) \neq 0$
1/2	$g(\mu_F) = 0$

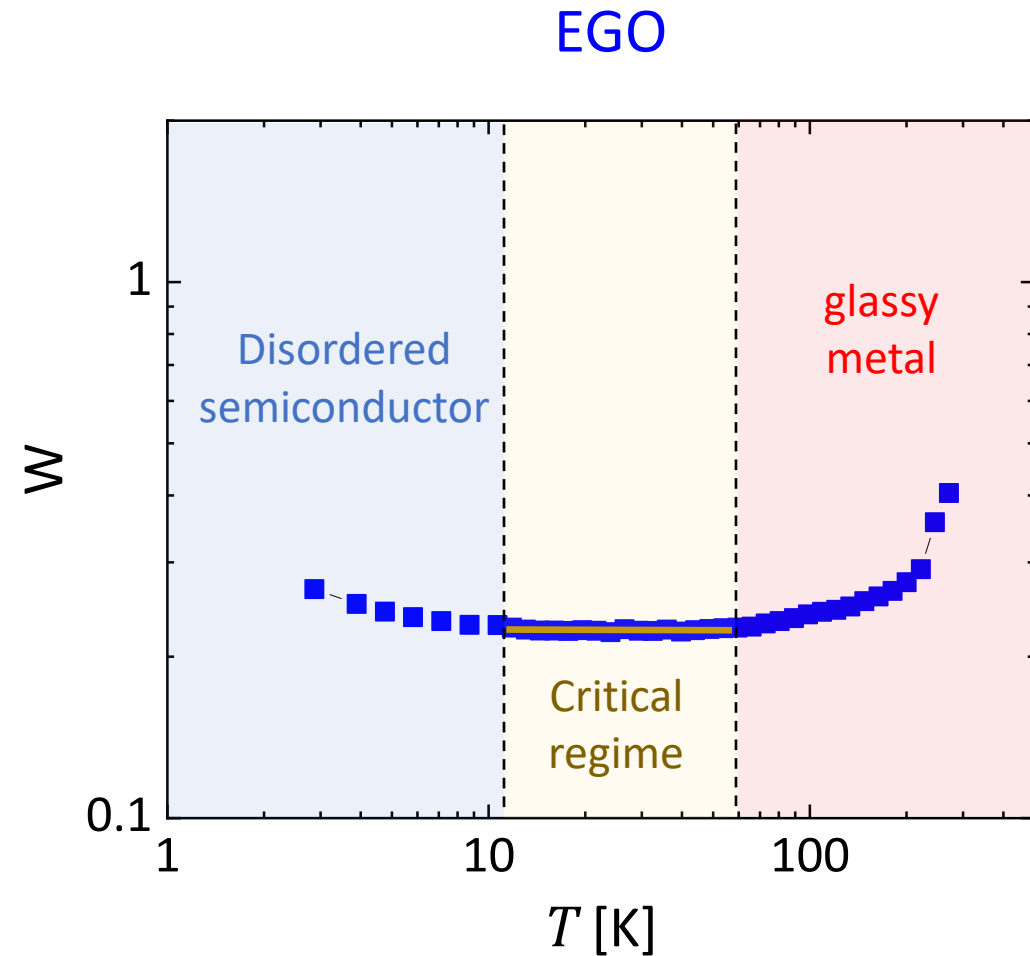
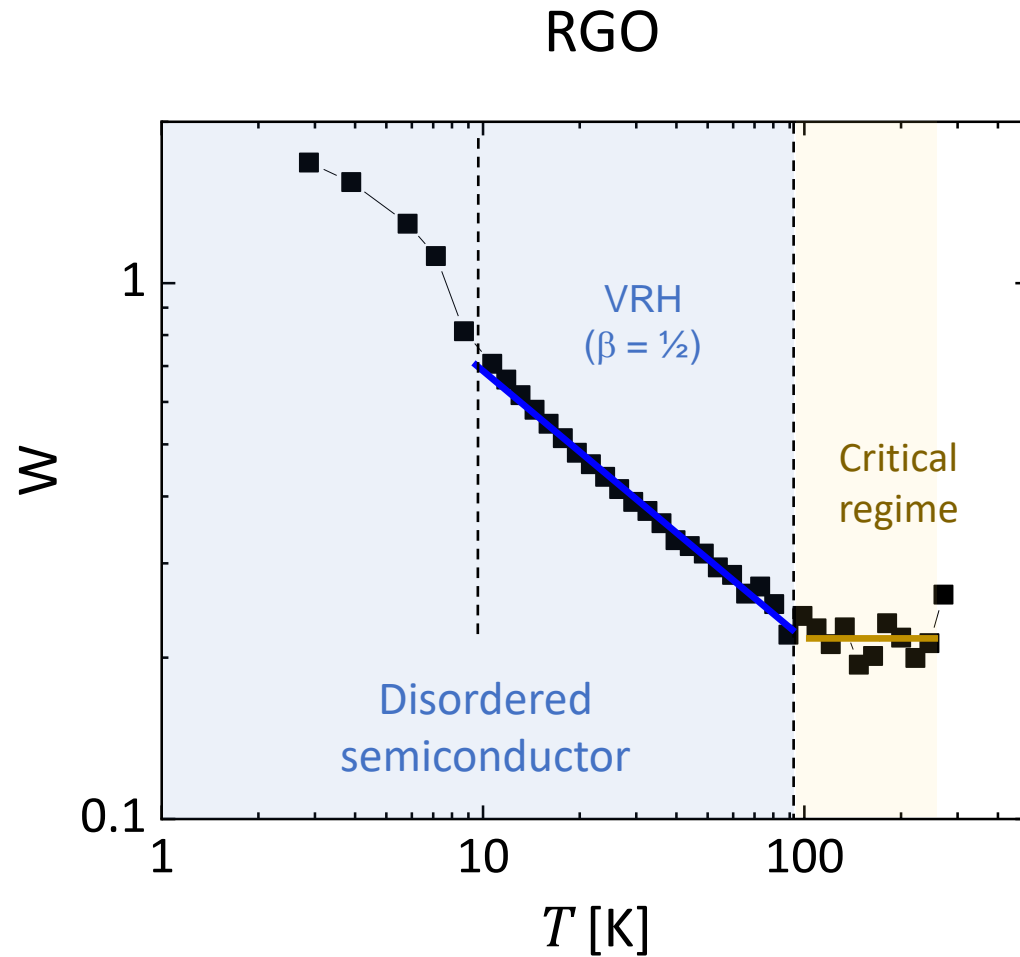
➔ $\rho(T) \sim T^{-m}$

ξ : localisation length



normalised resistivity

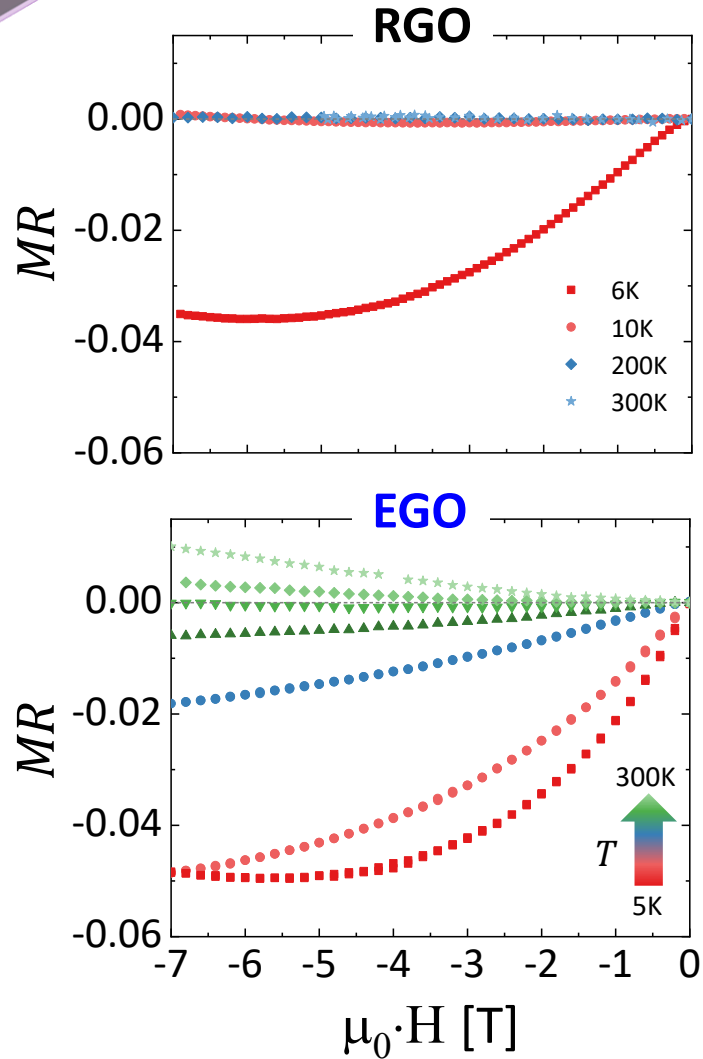
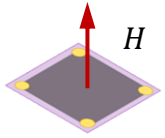




Observed for 35 different RGO systems!!

A. Kovtun et al., *ACS Nano* 15, 2654 (2021)

activation energy $W = -\frac{\partial \ln \rho(T)}{\partial \ln T}$



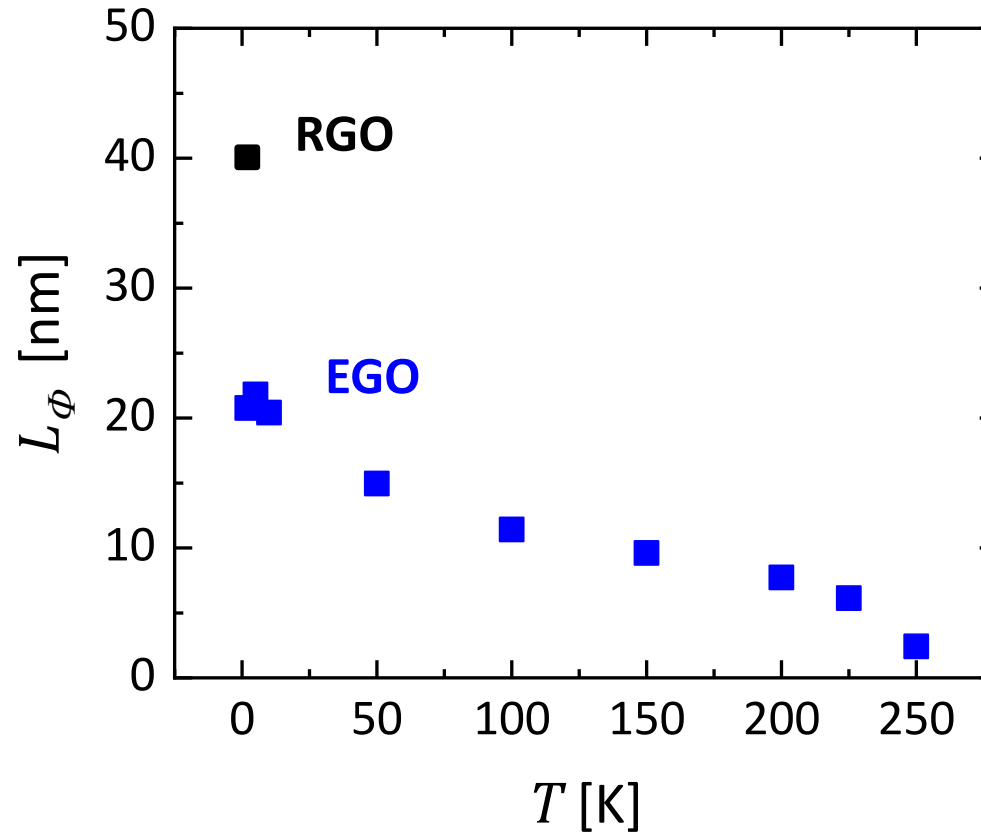
$$MR(T) = \frac{\rho(T, H) - \rho(T, 0)}{\rho(T, 0)}$$

Weak Localization effects

$$\frac{MR - \beta \cdot \mu_0 \cdot H^2}{\rho} = -C \cdot L_\phi^3 \cdot H^2 \quad \text{for } \mu_0 H \lesssim 2T$$

localization length

P. A. Lee, *Rev. Mod. Phys.* 57, 2 (1985)

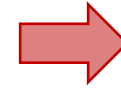


Electrical noise measurements



voltage-spectral density

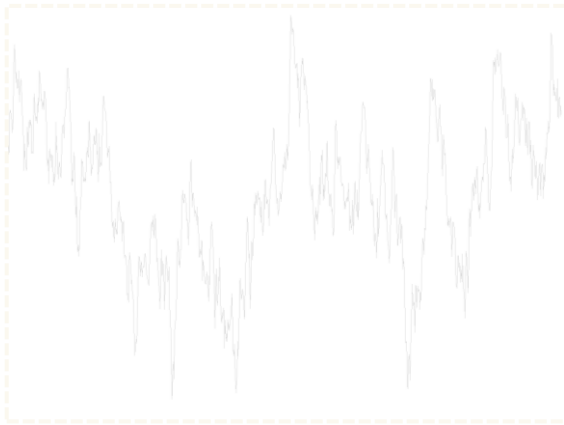
$$S_V(f) \approx \frac{K(I,T)}{f} + S_{white}$$



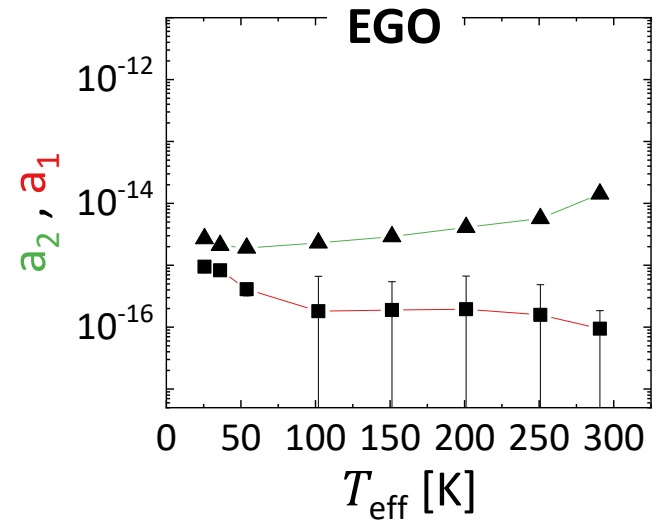
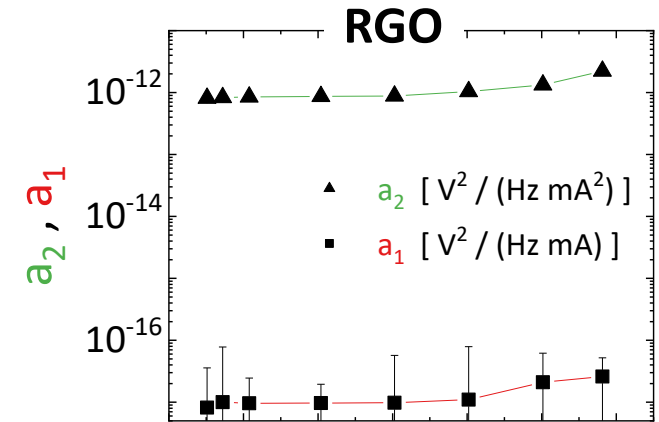
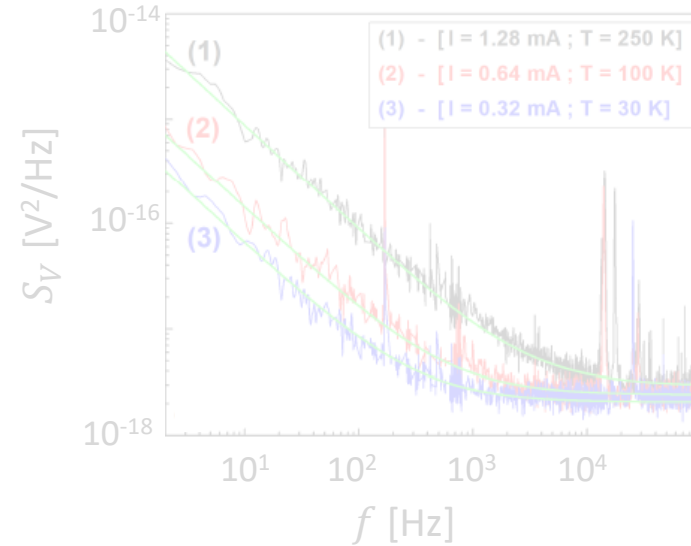
$$K(I,T) = a_2 I^2 + a_1 I + a_0$$

flicker noise

ELECTRICAL NOISE



fluctuation of an electrical quantity



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Lab



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(Dir)



Andrea Liscio
(Res)

Emanuele Treossi
(Res)

Xia Zhenyuan
(Res)

Fabrizio Poletti
(former fellow)



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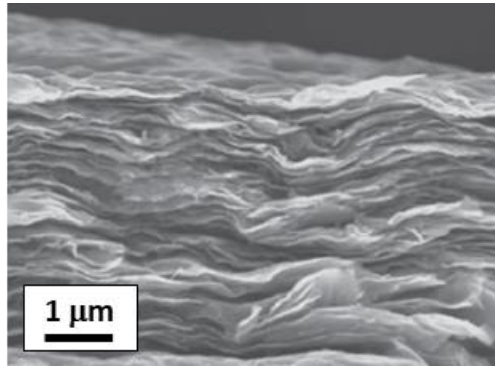
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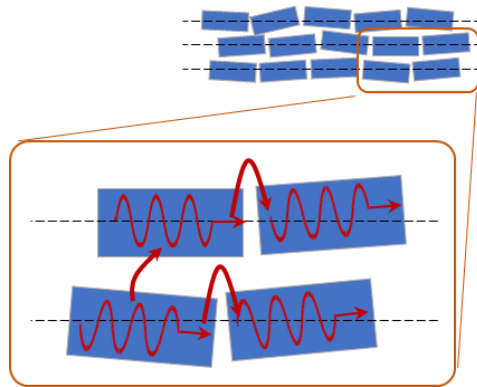
Carlo Barone
(Prof)

Sergio Pagano
(Prof)

University of
Salerno (IT)



- graphene-related materials (GRM) to study electrical properties of networks



- similar **macroscopic** electrical resistivities, different charge transport behavior depending on network **nano**- and **micro**- scale structure

Let's discuss...

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